

<b>Notice of References Cited</b>		Application/Control No. 10/559,831	Applicant(s)/Patent Under Reexamination YOO, WOONG-TUK	
		Examiner MICHAEL VANCHY JR	Art Unit 2624	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,594,377 B1	07-2003	Kim et al.	382/117
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